

								PAGE 1 OF 1
FC	RM P	TO-892		NT OF COMMERCE ADEMARK OFFICE	SERIAL NO. 09/189,572	GROUP ART UNIT 2782	ATTACHM TO PAPER	
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H			* A copy of this	reference is not being	furnished with this	office action.		
			(See Manual	of Patent Examining	Procedure, section	707.05(a).)		



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FORM PTO-1449	Attorney Docket Number	\$2270/PYI/X3
	Application Number	Not Yet Assigned
INFORMATION DISCLOSURE	Filing Date	Filed Herewith
STATEMENT BY APPLICANT	Applicant(s)	Paul K. Kavanaugh et al.
	Group Art Unit	Not Yet Assigned
(use as many sheets as necessary)	Examiner Name	Not Yet Assigned

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	OTHER DOCUMENTS							
EXAMINER INITIALS	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.							

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SIGNATURE	Claro Pake	CONSIDERED	1/25/2001

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.